

Notice of References Cited	Application/Control No. 10/634,176	Applicant(s)/Patent Under Reexamination TEOH ET AL.	
	Examiner (Jackie) Tan-Uyen T. Ho	Art Unit 3731	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,638,291	10-2003	Ferrera et al.	606/191
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
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	J	US-			
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FOREIGN PATENT DOCUMENTS

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	N					
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NON-PATENT DOCUMENTS

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